

**Notice of References Cited**

Application/Control No.

09/447,227

Applicant(s)/Patent Under

Reexamination  
SHULTS ET AL.

Examiner

Robert L. Nasser

Art Unit

3736

Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,011,984	01-2000	Van Antwerp et al.	600/317
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
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